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Application/Control No.	Applicant(s)/Patent under Reexamination
10/651,450	ITOU ET AL.
Examiner	Art Unit
Patrick H. Mackey	3651

SEARCHED			
Class	Subclass	Date	Examiner
270	32 37 45		
493	444		
	445	9/27/2004	РНМ
Update	Search	3/3/2005	РНМ
Update	Search	6/14/2005	РНМ
Update	Search	1/3/2006	РНМ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEA	RCHS	ES STRATEGY)
		DATE	EXMR
Text Search		9/27/2004	РНМ